

Substitute for form 1449/PTO			<b>Complete if Known</b>		
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)			<b>Application Number</b>	10/563,982-Conf. #7386	
			<b>Filing Date</b>	April 2, 2007	
			<b>First Named Inventor</b>	Roland Scholl	
			<b>Art Unit</b>	N/A	
			<b>Examiner Name</b>	Not Yet Assigned	
<b>Sheet</b>	1	of	1	<b>Attorney Docket Number</b>	13077-00118-US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number: Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/n.m./	AA*	US-5,246,897	09-21-1993	Ono et al	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/n.m./	BA	DE-3832472	03-29-1990	Siemens AG	See Abstract
/n.m./	BB	DE-4226211	02-11-1993	Asahi Glass Co Ltd	See US 5,246,897
/n.m./	BC	DE-4418600	11-30-1995	Fraunhofer Ges Forschung	See Abstract
/n.m./	BD	DE-10126377	10-24-2002	Fraunhofer Ges Forschung	See Abstract

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \* CITE NO.: Those application(s) which are marked with a single asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		T <sup>6</sup>
/n.m./	CA	"Standard Test Method for Determining Particle Size Distribution of Alumina or Quartz by Laser Light Scattering", ASTM International, 2001, Designation C 1070-01, pp. 1-3.		
/n.m./	CB	"Die Europäische Norm En 821-1, 'Hochleistungskeramik' 1995.		
/n.m./	CC	"Determination of the Thermal Expansion of Solids; Basic Rules", Die Europäische Norm 51 045, 1989, See Specification p. 15.		

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Ngoclan Mai/	Date Considered	08/19/2009
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